

**G2306****N-CHANNEL ENHANCEMENT MODE POWER MOSFET**

BVDSS	20V
RDS(ON)	32mΩ
ID	5.3A

**Description**

The G2306 utilized advanced processing techniques to achieve the lowest possible on-resistance, extremely efficient and cost-effectiveness device.

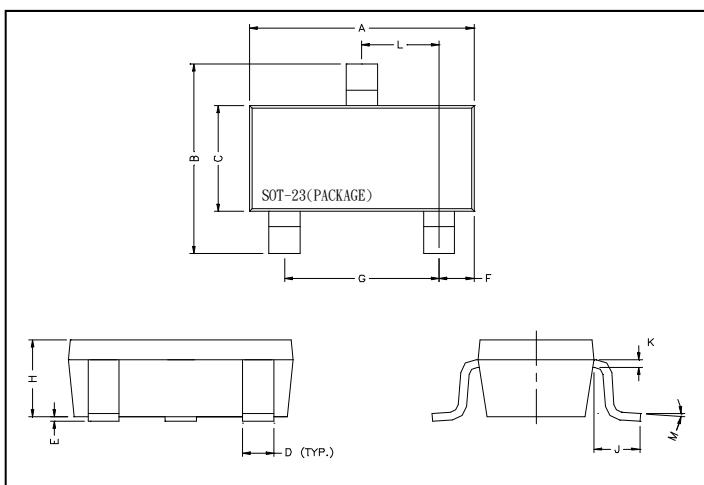
The SOT-23 package is universally used for all commercial-industrial applications.

**Features**

- Capable of 2.5V gate drive
- Lower on-resistance
- Reliable and Rugged

**Applications**

- Power Management in Notebook Computer
- Portable Equipment
- Battery Powered System.

**Package Dimensions**

N-Channel		Marking :		
REF.	Millimeter	REF.	Millimeter	
	Min.	Max.	Min.	Max.
A	2.70	3.10	G	1.90 REF.
B	2.40	2.80	H	1.00 1.30
C	1.40	1.60	K	0.10 0.20
D	0.35	0.50	J	0.40 -
E	0	0.10	L	0.85 1.15
F	0.45	0.55	M	0° 10°

**Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	V
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @TA=25°C	5.3	A
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @TA=70°C	4.3	A
Pulsed Drain Current <sup>1,2</sup>	I <sub>DM</sub>	10	A
Power Dissipation	P <sub>D</sub> @TA=25°C	1.38	W
Linear Derating Factor		0.01	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 ~ +150	°C

**Thermal Data**

Parameter	Symbol	Ratings	Unit
Thermal Resistance Junction-ambient <sup>3</sup> Max.	R <sub>thj-a</sub>	90	°C/W

## Electrical Characteristics( $T_j = 25^\circ\text{C}$ Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	-	0.1	-	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.5	-	1.2	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Forward Transconductance	$\text{g}_{\text{fs}}$	-	13	-	S	$\text{V}_{\text{DS}}=5.0\text{V}, \text{I}_D=5.3\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current( $T_j=25^\circ\text{C}$ )	$\text{I}_{\text{DSS}}$	-	-	1	$\mu\text{A}$	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current( $T_j=70^\circ\text{C}$ )		-	-	10	$\mu\text{A}$	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	-	-	30	$\text{m}\Omega$	$\text{I}_D=5.3\text{A}, \text{V}_{\text{GS}}=10\text{V}$
		-	-	35		$\text{I}_D=5.3\text{A}, \text{V}_{\text{GS}}=4.5\text{V}$
		-	-	50		$\text{I}_D=2.6\text{A}, \text{V}_{\text{GS}}=2.5\text{V}$
		-	-	90		$\text{I}_D=1.0\text{A}, \text{V}_{\text{GS}}=1.8\text{V}$
Total Gate Charge <sup>2</sup>	$\text{Q}_g$	-	8.7	-	nC	$\text{I}_D=5.3\text{A}$
Gate-Source Charge	$\text{Q}_{\text{gs}}$	-	1.5	-		$\text{V}_{\text{DS}}=10\text{V}$
Gate-Drain ("Miller") Charge	$\text{Q}_{\text{gd}}$	-	3.6	-		$\text{V}_{\text{GS}}=4.5\text{V}$
Turn-on Delay Time <sup>2</sup>	$\text{T}_{\text{d(on)}}$	-	6	-	ns	$\text{V}_{\text{DS}}=15\text{V}$
Rise Time	$\text{T}_r$	-	14	-		$\text{I}_D=1\text{A}$
Turn-off Delay Time	$\text{T}_{\text{d(off)}}$	-	18.4	-		$\text{V}_{\text{GS}}=10\text{V}$
Fall Time	$\text{T}_f$	-	2.8	-		$\text{R}_G=2\Omega$
Input Capacitance	$\text{C}_{\text{iss}}$	-	603	-	pF	$\text{R}_D=15\Omega$
Output Capacitance	$\text{C}_{\text{oss}}$	-	144	-		$\text{V}_{\text{GS}}=0\text{V}$
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	111	-		$\text{V}_{\text{DS}}=15\text{V}$ $f=1.0\text{MHz}$

## Source-Drain Diode

Forward On Voltage <sup>2</sup>	$\text{V}_{\text{SD}}$	-	-	1.2	V	$\text{I}_S=1.2\text{A}, \text{V}_{\text{GS}}=0 \text{ } T_j=25^\circ\text{C}$
Reverse Recovery Time	$\text{T}_{\text{rr}}$	-	16.8	-	ns	$\text{I}_S=5.0\text{A}, \text{V}_{\text{GS}}=0$
Reverse Recovery Charge	$\text{Q}_{\text{rr}}$	-	11	-	nC	$d\text{I}/dt=100\text{A}/\mu\text{s}$

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board;  $270^\circ\text{C}/\text{w}$  when mounted on min. copper pad.

## Characteristics Curve

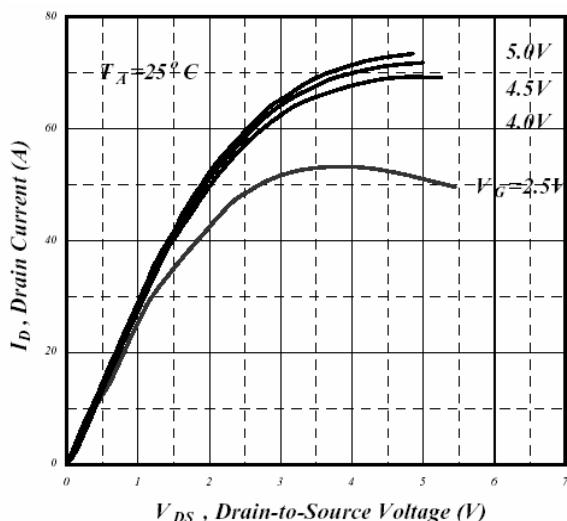


Fig 1. Typical Output Characteristics

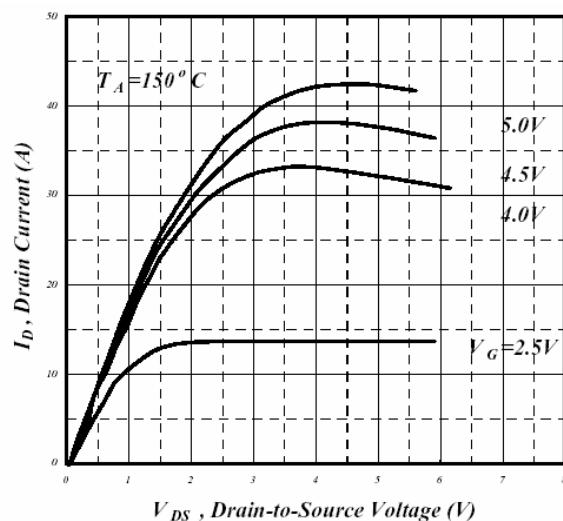


Fig 2. Typical Output Characteristics

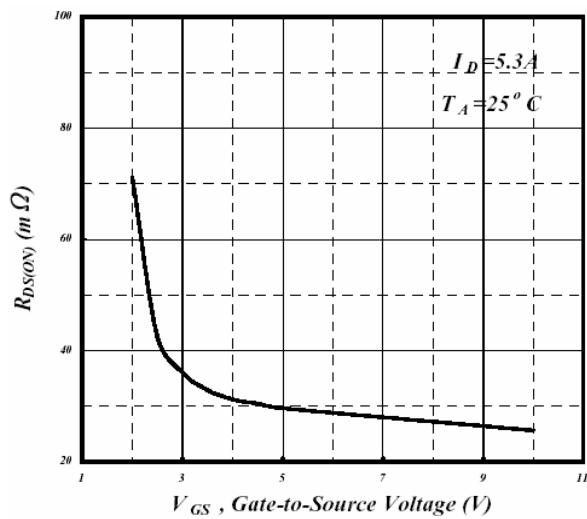


Fig 3. On-Resistance v.s. Gate Voltage

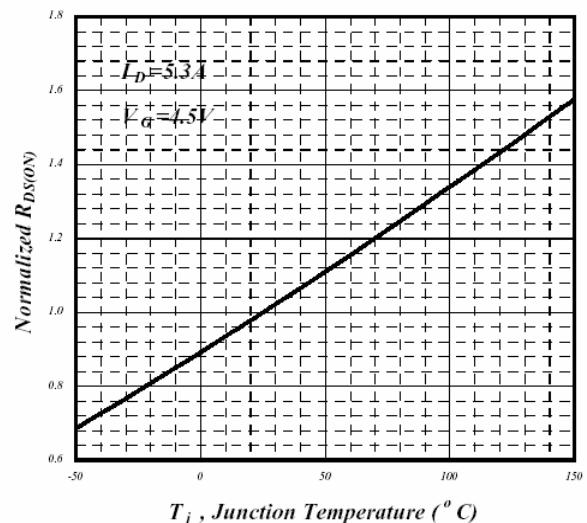


Fig 4. Normalized On-Resistance v.s. Junction Temperature

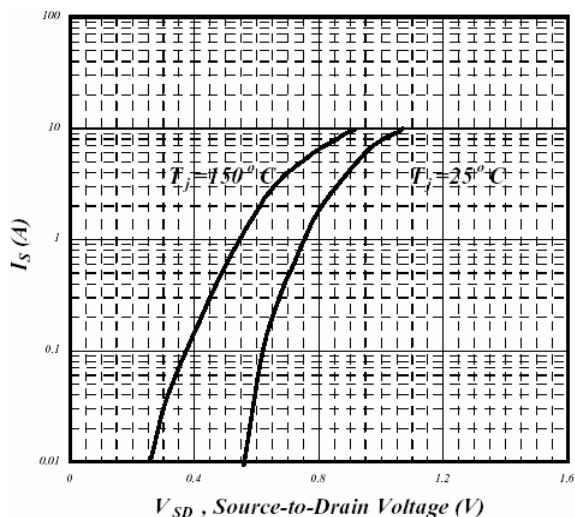


Fig 5. Forward Characteristic of Reverse Diode

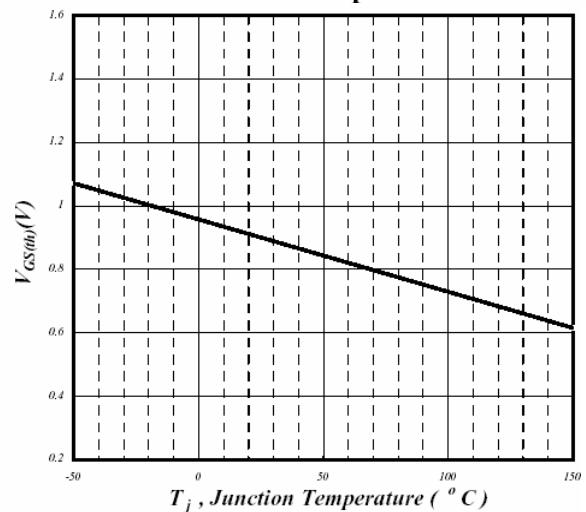


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

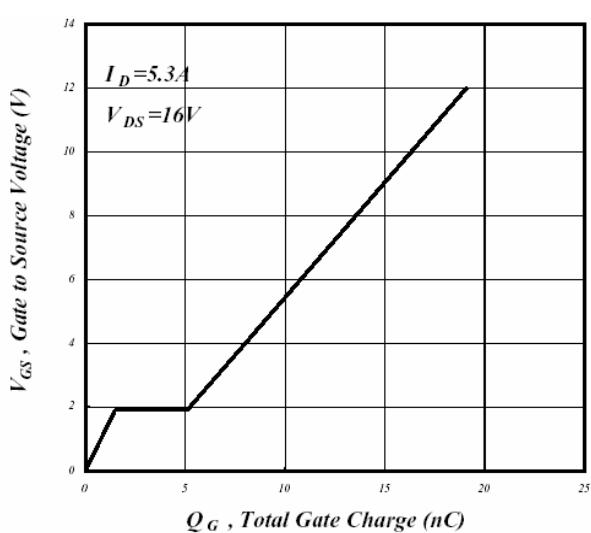


Fig 7. Gate Charge Characteristics

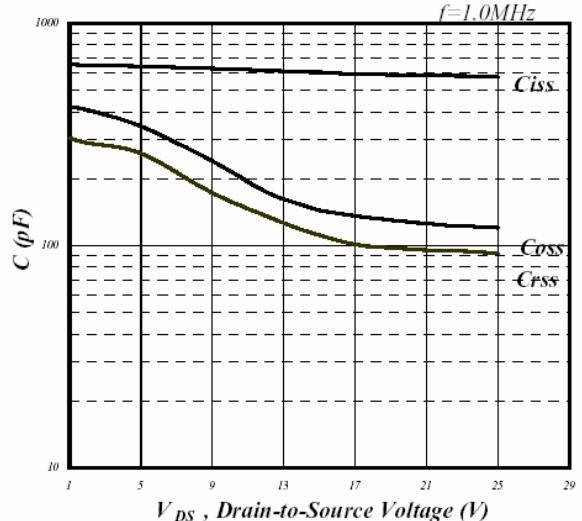
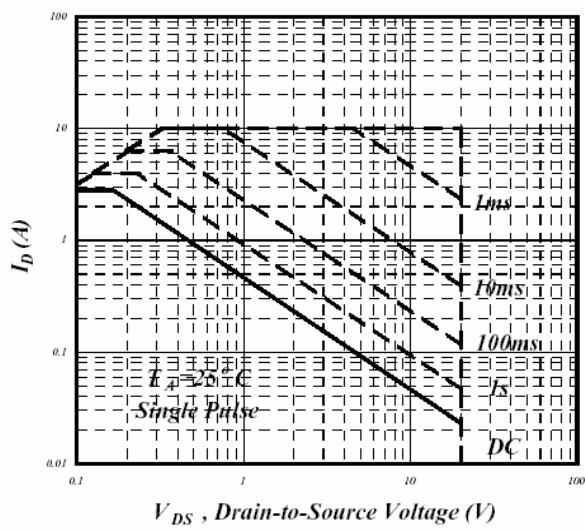
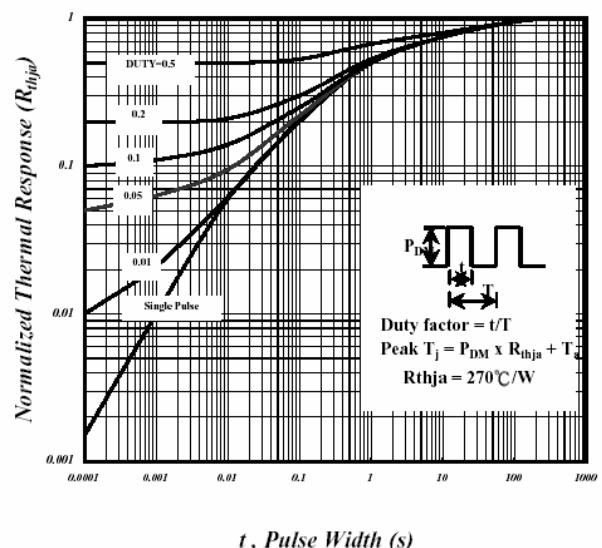


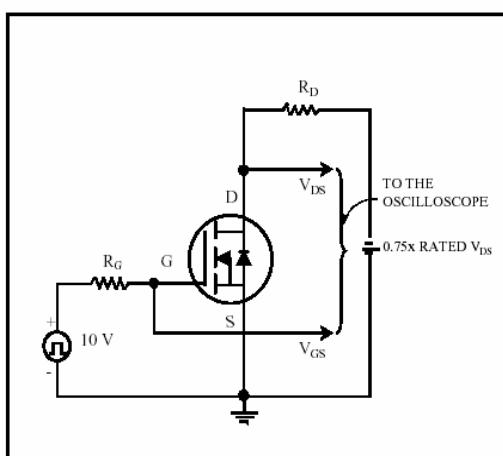
Fig 8. Typical Capacitance Characteristics



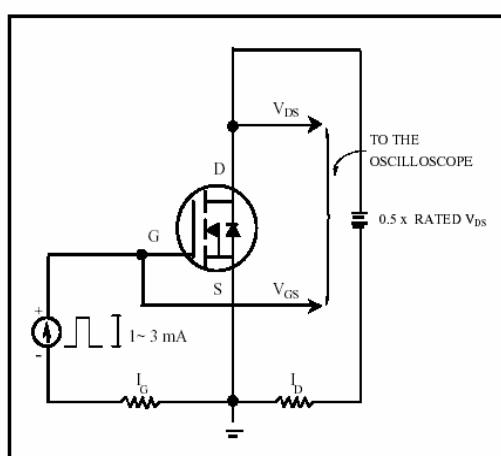
**Fig 9. Maximum Safe Operating Area**



**Fig10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Circuit**



**Fig 12. Gate Charge Circuit**

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